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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Inventors: Takahiro SHOJI, et al. Art Unit: 2661
Application No.: 10/069,380
Filed: February 26, 2002
For: BASE STATION APPARATUS AND CHANNEL ALLOCATION METHOD

INFORMATION DISCLOSURE STATEMENT

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Assistant Commissioner of Patents
Washington, DC 20231

APR 14 2004

Technology Center 2600

Dear Sir:

Pursuant to Rules 56 and 99, Applicants hereby call the attention of the Patent Office to the art listed on the attached Form PTO 1449. All of these references were cited in a Japanese Office Action dated January 27, 2004 (English translation attached).

Applicants present this art so that the Patent Office may, in the first instance, determine any relevancy thereof to the presently claimed invention, see Beckman Instruments, Inc. v. Chemtronics, Inc., 439 F.2d 1369, 1380, 165 USPQ 355, 364 (5th Cir. 1970). Also see Patent Office Rules 104 and 106. Applicants respectfully request that this art be expressly considered during the prosecution of this application and made of record herein and appear among the "References Cited" on any patent to issue herefrom.

Respectfully submitted,

 Reg # 31,689

Date: April 13, 2004

James E. Ledbetter
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JEL/spp

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FOREIGN PATENT DOCUMENTS															
		DOCUMENT NUMBER								DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
														YES	NO
		0	8	1	2	6	0	4	9	05/1996	JP			Abstract	
		0	8	2	2	3	6	3	2	08/1996	JP			Abstract	
		1	0	0	7	5	4	8	8	03/1998	JP			Abstract	
		0	6	0	9	0	2	0	5	03/1994	JP			Abstract	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

DATE CONSIDERED

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.